Key Parameters

V_{DRM}	=	1600	V
I_{TAVM}	=	570	A
t_q	=	20	µs
I_{TSM}	=	8000	A
V_{TO}	=	1.10	V
r_T	=	0.750	m_Ω

Fast Switching Thyristor

5STF 06D1620

Doc. No. 5SYA 1033-02 Feb.99

Features

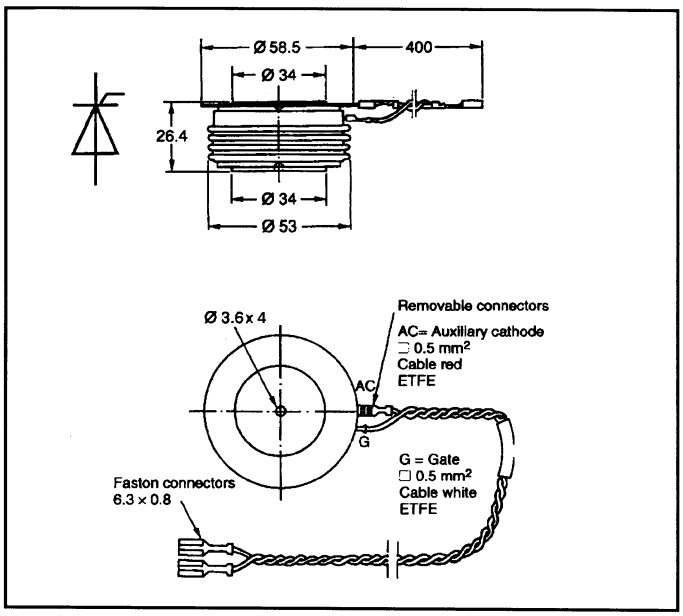
- Patented free-floating silicon technology
- Designed for traction and industrial applications
- Optimum switching performance

Blocking

Part number	5STF 06D1620	5STF 06D1420	5STF 06D1220	Conditions	
V_{DRM} V_{RRM}	1600 V	1400 V	1200 V	f = 50Hz, t_p = 10ms	
V_{RSM1}	1700 V	1500 V	1300 V	t_p= 5ms, single pulse	
I_{DRM}	≤ 100 mA			V_{DRM}	T_{vj} = 125°C
I_{RRM}	≤ 100 mA			V_{RRM}	
dv/dt_{crit}	500 V/µs		@ Exp.to 0.67xV_{DR}		

Mechanical data

F_m	Mounting force	nom	10 kN
		min	8 kN
		max	12 kN
a	Acceleration Device clamped		100 m/s²
m	Weight		0.30 kg
D_s	Surface creepage distance		25 mm
D_a	Air strike distance		14 mm



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On-state

I_{TAVM}	Max. average on-state current	570 A	Half sine wave, T_c = 70°C	
I_{TRMS}	Max. RMS on-state current	890 A		
I_{TSM}	Max. peak non-repetitive surge current	8000 A	t_p = 10 ms	T_{vj} = 125°C
		8700 A	t_p = 8.3 ms	
I^2t	Limiting load integral	320 kA²s	t_p = 10 ms	
		310 kA²s	t_p = 8.3 ms	
V_T	On-state voltage	1.85 V	I_T = 1000 A	
V_{TO}	Threshold voltage	1.10 V		
r_T	Slope resistance	0.750 mΩ	I_T = 330 - 1000 A	
I_H	Holding current	30-60 mA	T_{vj} = 25°C	
		15-50 mA	T_{vj} = 125°C	
I_L	Latching current	150-500 mA	T_{vj} = 25°C	
		50-300 mA	T_{vj} = 125°C	

Switching

di/dt_{crit}	Critical rate of rise of on-state current	300 A/µs	Cont.	$V_D \leq 0.67 \times V_{DRM}$	T_{vj} = 125°C
		600 A/µs	60 sec.	I_{TRM} = 1500 A	f = 50Hz
				I_{FG} = 2.0 A	t_r = 0.5µs
t_d	Delay time	≤ 2.0 µs	V_D =0.4xV_{DRM}	I_{FG} = 2.0 A	t_r = 0.5µs
t_q	Turn-off time	≤ 20 µs	V_D ≤0.67xV_{DRM}	I_{TRM} = 1500 A	T_{vj} = 125°C
			dv_D/dt=20V/µs	V_R > 100 V	
Q	Recovery charge min	150 µAs		di_T/dt= -20 A/µs	
	max	300 µAs			

Triggering

V_{GT}	Gate trigger voltage	2.6 V	T_{vj} = 25°C
I_{GT}	Gate trigger current	400 mA	T_{vj} = 25°C
V_{GD}	Gate non-trigger voltage	0.3 V	V_D = 0.4xV_{DRM}
I_{GD}	Gate non-trigger DC current	10 mA	V_D = 0.4xV_{DRM}
V_{FGM}	Peak forward gate voltage	12 V	
I_{FGM}	Peak forward gate current	10 A	
V_{RGM}	Peak reverse gate voltage	10 V	
P_G	Gate power losses	3 W	

Thermal

$T_{vj\ max}$	Max. junction temperature	125 °C	
$T_{vj\ stg}$	Storage temperature range	-40.. ..150°C	
R_{thJC}	Thermal resistance junction to case	70 K/kW	Anode side cooled
		90 K/kW	Cathode side cooled
		40 K/kW	Double side cooled
R_{thCH}	Thermal resistance case to heat sink	30 K/kW	Single side cooled
		15 K/kW	Double side cooled

Analytical function for transient thermal impedance:

$$Z_{thJC} = \sum_{i=1}^{n} R_i(1-e^{-t/\tau_i})$$

i	1	2	3	4
R_i (K/W)	0.0146	0.0242	0.0011	
τ_i (s)	1.5606	0.1698	0.0028	

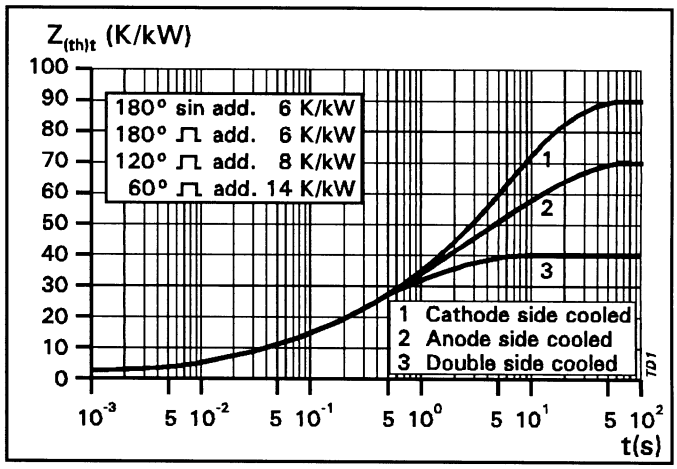

Fig.1 Transient thermal impedance, junction to case.

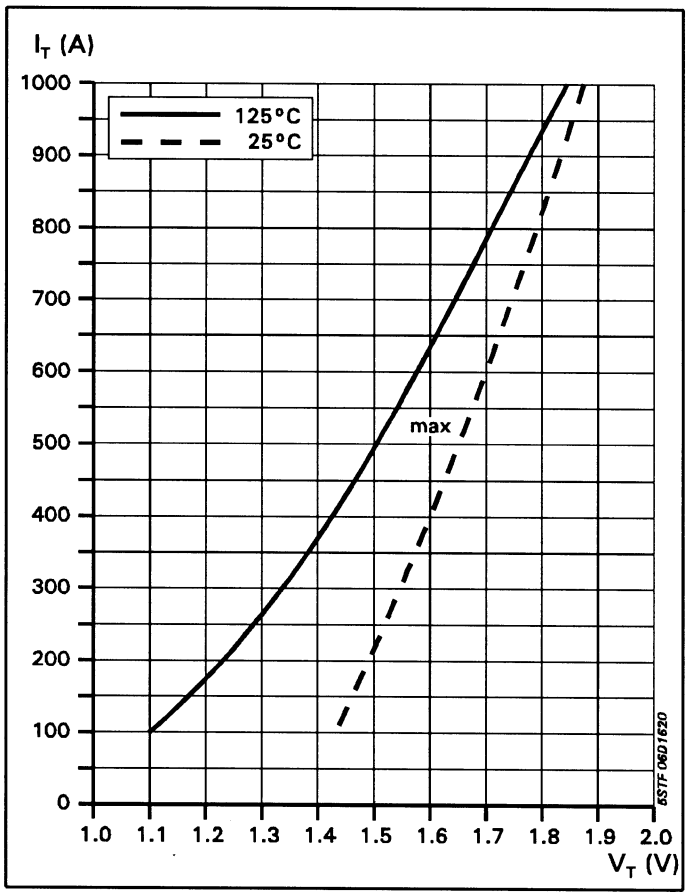

Fig.2 On-state characteristics.

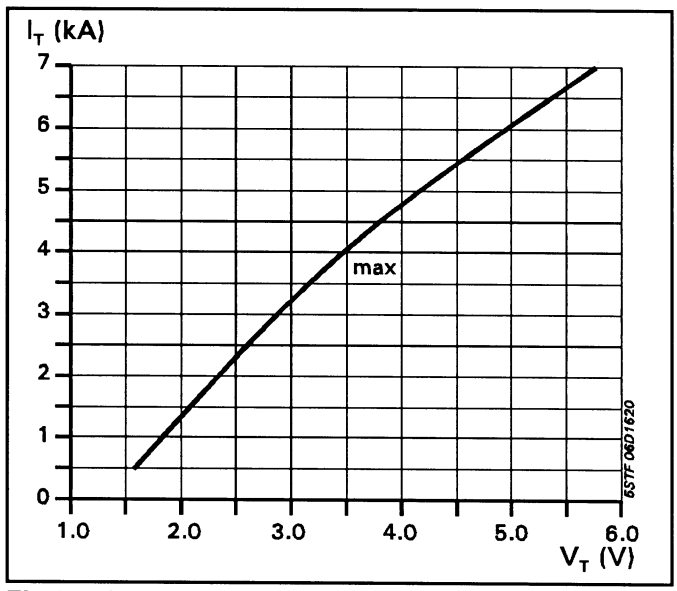

Fig.3 On-state characteristics.

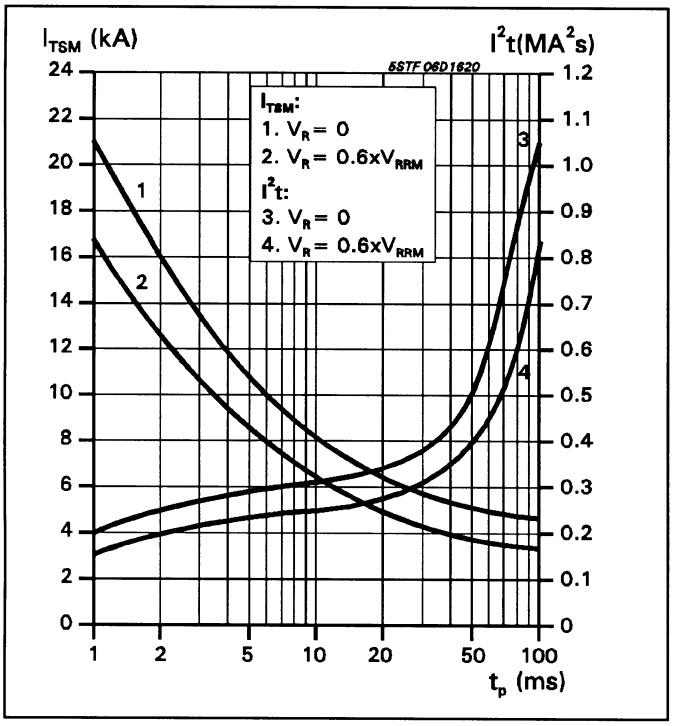

Fig.4 Surge on-state current vs pulse length. Half-sine wave.

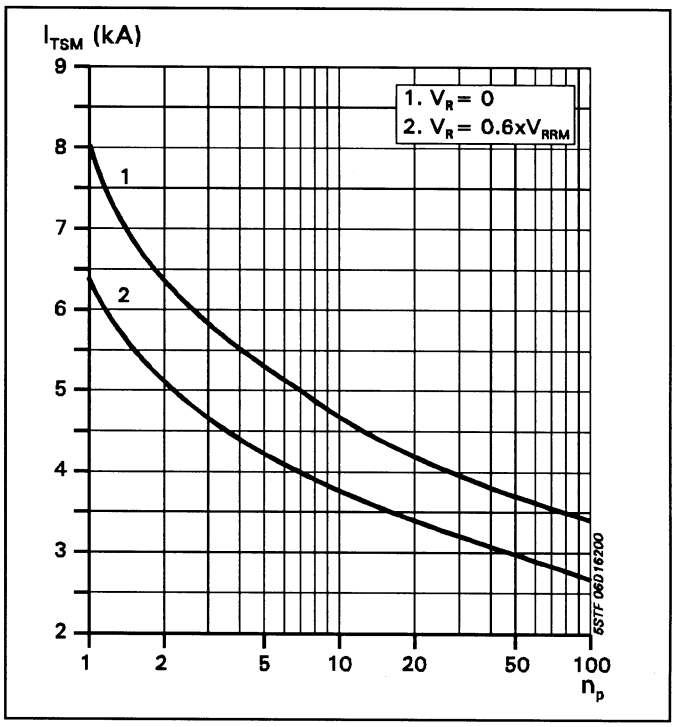

Fig.5 Surge on-state current vs number of pulses. Half-sine wave, 10ms, 50Hz.

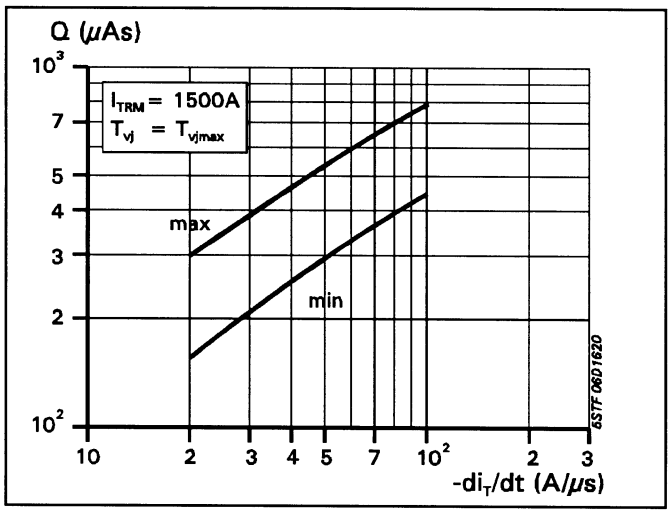

Fig.6 Recovery charge vs decay rate of on-state current.

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